Notice of References Cited Application/Control No. 10/736,432 Examiner Duc M. Nguyen Applicant(s)/Patent Under Reexamination DEMIR ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,587,513	07-2003	Ichihara, Masaki	375/296
*	В	US-6,373,902	04-2002	Park et al.	375/296
*	С	US-7,058,139	06-2006	Duperray, David Benoit Didier	375/297
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Ή	US-			
	_	US-			
	J	US-			
	ĸ	US-			
	L	US-			7
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					•
	0					
	Р					
	Q					
	R				•	·
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.